

Onity Inc., A Division of UTCFS

Advance RFID BTLE FCC 15.209:2015 FCC 15.225:2015 13.56 MHz Radio

Report # ONIT0011.1



NVLAP Lab Code: 200630-0

This report must not be used to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the federal government of the United States of America. This Report may only be duplicated in its entirety





Last Date of Test: October 30, 2015 Onity Inc., A Division of UTCFS Model: Advance RFID BTLE For a complete model list, reference document P/N 10104089P1 (DOC, ADVANCE 3 RFID BTLE MODEL LIST)

Radio Equipment Testing

Standards

Specification	Method
FCC 15.209:2015	ANEL CE2 10:2012
FCC 15.225:2015	ANSI C63.10:2013

Results

Method Clause	Test Description	Applied	Results	Comments
6.2	Powerline Conducted Emissions	No	N/A	Not required for a battery powered EUT.
6.2 6.4	Field Strength of Fundamental	Yes	Pass	
6.4	Field Strength of Spurious Emissions Less Than 30 MHz	Yes	Pass	
6.5	Field Strength of Spurious Emissions Greater Than 30 MHz	Yes	Pass	
6.8	Frequency Stability	Yes	Pass	

Deviations From Test Standards

None

Approved By:

Kyle Holgate, Operations Manager

Product compliance is the responsibility of the client; therefore, the tests and equipment modes of operation represented in this report were agreed upon by the client, prior to testing. The results of this test pertain only to the sample(s) tested. The specific description is noted in each of the individual sections of the test report supporting this certificate of test. This report reflects only those tests from the referenced standards shown in the certificate of test. It does not include inspection or verification of labels, identification, marking or user information.

REVISION HISTORY



Revision Number	Description	Date	Page Number
00	None		

ACCREDITATIONS AND AUTHORIZATIONS



United States

FCC - Designated by the FCC as a Telecommunications Certification Body (TCB). Certification chambers, Open Area Test Sites, and conducted measurement facilities are listed with the FCC.

A2LA - Accredited by A2LA to ISO / IEC 17065 as a product certifier. This allows Northwest EMC to certify transmitters to FCC and IC specifications.

NVLAP - Each laboratory is accredited by NVLAP to ISO 17025

Canada

IC - Recognized by Industry Canada as a Certification Body (CB). Certification chambers and Open Area Test Sites are filed with IC.

European Union

European Commission – Validated by the European Commission as a Conformity Assessment Body (CAB) under the EMC directive and as a Notified Body under the R&TTE Directive.

Australia/New Zealand

ACMA - Recognized by ACMA as a CAB for the acceptance of test data.

Korea

MSIP / RRA - Recognized by KCC's RRA as a CAB for the acceptance of test data.

Japan

VCCI - Associate Member of the VCCI. Conducted and radiated measurement facilities are registered.

Taiwan

BSMI – Recognized by BSMI as a CAB for the acceptance of test data.

NCC - Recognized by NCC as a CAB for the acceptance of test data.

Singapore

IDA – Recognized by IDA as a CAB for the acceptance of test data.

Israel

MOC – Recognized by MOC as a CAB for the acceptance of test data.

Hong Kong

OFCA – Recognized by OFCA as a CAB for the acceptance of test data.

Vietnam

MIC – Recognized by MIC as a CAB for the acceptance of test data.

SCOPE

For details on the Scopes of our Accreditations, please visit: <u>http://www.nwemc.com/accreditations/</u> http://gsi.nist.gov/global/docs/cabs/designations.html

MEASUREMENT UNCERTAINTY



Measurement Uncertainty

When a measurement is made, the result will be different from the true or theoretically correct value. The difference is the result of tolerances in the measurement system that cannot be completely eliminated. To the extent that technology allows us, it has been our aim to minimize this error. Measurement uncertainty is a statistical expression of measurement error qualified by a probability distribution.

A measurement uncertainty estimation has been performed for each test per our internal quality document WP 342. The estimation is used to compare the measured result with its "true" or theoretically correct value. The expanded measurement uncertainty (K=2) for each test is on each data sheet. Our measurement data meets or exceeds the measurement uncertainty requirements of the applicable specification; therefore, the test data can be compared directly to the specification limit to determine compliance. The calculations for estimating measurement uncertainty are based upon ETSI TR 100 028 (or CISPR 16-4-2 as applicable), and are available upon request.

The following table represents the Measurement Uncertainty (MU) budgets for each of the tests that may be contained in this report.

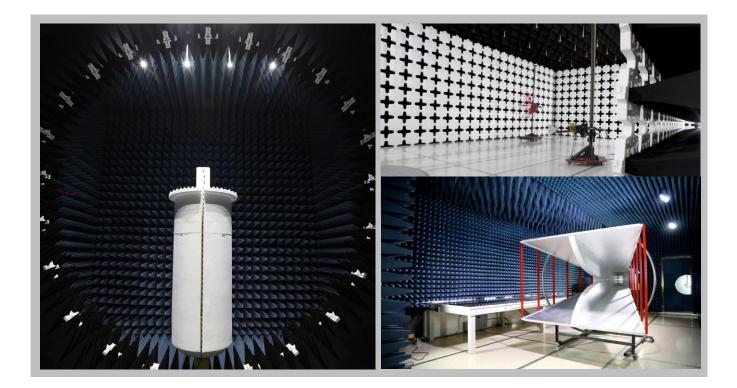
Test	+ MU	- MU
Frequency Accuracy (Hz)	0.0007%	-0.0007%
Amplitude Accuracy (dB)	1.2 dB	-1.2 dB
Conducted Power (dB)	0.3 dB	-0.3 dB
Radiated Power via Substitution (dB)	0.7 dB	-0.7 dB
Temperature (degrees C)	0.7°C	-0.7°C
Humidity (% RH)	2.5% RH	-2.5% RH
Voltage (AC)	1.0%	-1.0%
Voltage (DC)	0.7%	-0.7%
Field Strength (dB)	5.2 dB	-5.2 dB
AC Powerline Conducted Emissions (dB)	2.4 dB	-2.4 dB

FACILITIES





California Labs OC01-13 41 Tesla Irvine, CA 92618 (949) 861-8918	Minnesota Labs MN01-08, MN10 9349 W Broadway Ave. Brooklyn Park, MN 55445 (612)-638-5136	New York Labs NY01-04 4939 Jordan Rd. Elbridge, NY 13060 (315) 554-8214	Oregon Labs EV01-12 22975 NW Evergreen Pkwy Hillsboro, OR 97124 (503) 844-4066	Texas Labs TX01-09 3801 E Plano Pkwy Plano, TX 75074 (469) 304-5255	Washington Labs NC01-05 19201 120 th Ave NE Bothell, WA 9801 (425)984-6600							
NVLAP												
NVLAP Lab Code: 200676-0	NVLAP Lab Code: 200881-0	NVLAP Lab Code: 200761-0	NVLAP Lab Code: 200630-0	NVLAP Lab Code:201049-0	NVLAP Lab Code: 200629-0							
	Industry Canada											
2834B-1, 2834B-3	2834E-1	N/A	2834D-1, 2834D-2	2834G-1	2834F-1							
		BS	МІ									
SL2-IN-E-1154R	SL2-IN-E-1152R	N/A	SL2-IN-E-1017	SL2-IN-E-1158R	SL2-IN-E-1153R							
		VC	CI									
A-0029	A-0109	N/A	A-0108	A-0201	A-0110							
Recognized Phase I CAB for ACMA, BSMI, IDA, KCC/RRA, MIC, MOC, NCC, OFCA												
US0158	US0175	N/A	US0017	US0191	US0157							
	_											



PRODUCT DESCRIPTION



Client and Equipment Under Test (EUT) Information

Company Name:	Onity Inc., A Division of UTCFS
Address:	4001 Fairview Industrial Drive
City, State, Zip:	Salem, 97302-1142
Test Requested By:	Mike Gersztyn
Model:	Advance RFID BTLE
First Date of Test:	October 24, 2015
Last Date of Test:	October 30, 2015
Receipt Date of Samples:	October 24, 2015
Equipment Design Stage:	Production
Equipment Condition:	No Damage

Information Provided by the Party Requesting the Test

Functional Description of the EUT:

RFID card controlled lock w/ DirectKey module

Testing Objective:

To demonstrate compliance to FCC Part 15.225 specifications





Configuration ONIT0011-1

EUT			
Description	Manufacturer	Model/Part Number	Serial Number
RFID Door lock	Onity Inc., A Division of UTCFS	Advance RFID BTLE	None

MODIFICATIONS



Equipment Modifications

Item	Date	Test	Modification	Note	Disposition of EUT
1	10/24/2015	Field Strength of Fundamental	EUT remained at Northwest EMC following the test.		
2	10/24/2015	Field Strength of Spurious Emissions less than 30 MHz	Tested as delivered to Test Station.	Modified during this test. No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.
3	10/24/2015	Field Strength of Spurious Emissions greater than 30 MHz		No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.
4	10/30/2015	Frequency Stability	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	Scheduled testing was completed.

ENC

FIELD STRENGTH OF FUNDAMENTAL

Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data. The test data represents the configuration / operating mode/ model that produced the highest emission levels as compared to the specification limit.

MODES OF OPERATION

Continuous Tx at 13.56MHz

POWER SETTINGS INVESTIGATED

Battery

CONFIGURATIONS INVESTIGATED

ONIT0011 - 1

FREQUENCY RANGE INVESTIGATED

Start Frequency 12.5 MHz

Stop Frequency 14.5 MHz

SAMPLE CALCULATIONS

Radiated Emissions: Field Strength = Measured Level + Antenna Factor + Cable Factor - Amplifier Gain + Distance Adjustment Factor + External Attenuation

TEST EQUIPMENT

Description	Manufacturer	Model	ID	Last Cal.	Interval
Cable	None	10m Test Distance Cable	EVL	5/11/2015	12 mo
Antenna, Loop	EMCO	6502	AOA	6/24/2014	24 mo
Analyzer - Spectrum Analyzer	Agilent	E4443A	AFB	3/17/2015	12 mo

TEST DESCRIPTION

The antennas to be used with the EUT were tested. The EUT was continuously transmitting while set to the channel specified.

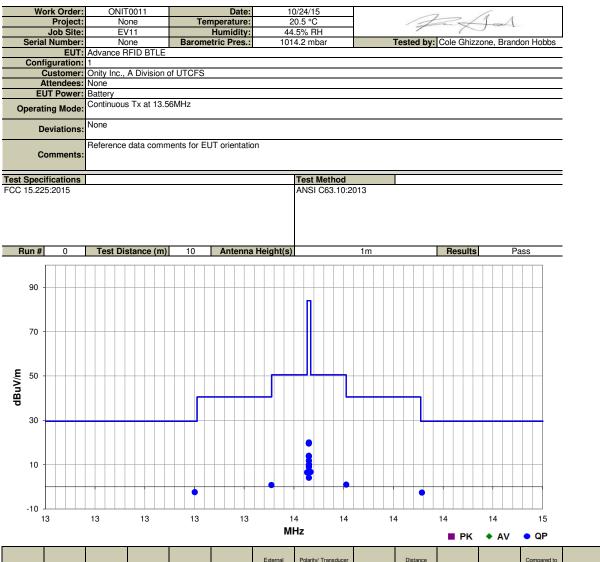
While scanning, fundamental carrier from the EUT was maximized by rotating the EUT, adjusting the measurement antenna height and orientation in 3 orthogonal planes, the EUT and/or associated antenna is positioned in 3 orthogonal planes (per ANSI C63.10). An active loop antenna was used for this test in order to provide sufficient measurement sensitivity.

As outlined in 15.209(e) and 15.31(f)(2), measurements may be performed at a distance closer than what is specified with the limit. The limit at the specified distance is shown on the data sheet. Measurements are made at a closer distance and the data is adjusted using a distance correction factor of 40dB/decade for comparison to the limit.



FIELD STRENGTH OF FUNDAMENTAL

PSA-ESCI 2015.07.01 EmiR5 2015.08.28



Freq (MHz)	Amplitude (dBuV)	Factor (dB)	Antenna Height (meters)	Azimuth (degrees)	Test Distance (meters)	External Attenuation (dB)	Polarity/ Transducer Type	Detector	Distance Adjustment (dB)	Adjusted (dBuV/m)	Spec. Limit (dBuV/m)	Compared to Spec. (dB)	Comments
13.101	5.9	10.8	1.0	302.0	10.0	0.0	See Comments	QP	-19.1	-2.4	29.5	-31.9	Ant. Perp to floor/perp EUT, EUT On Side
14.015	5.7	10.8	1.0	185.0	10.0	0.0	See Comments	QP	-19.1	-2.6	29.5	-32.1	Ant. Perp to floor/perp EUT, EUT On Side
13.710	9.3	10.8	1.0	270.0	10.0	0.0	See Comments	QP	-19.1	1.0	40.5	-39.5	Ant. Perp to floor/perp EUT, EUT On Side
13.409	9.1	10.8	1.0	271.0	10.0	0.0	See Comments	QP	-19.1	0.8	40.5	-39.7	Ant. Perp to floor/perp EUT, EUT On Side
13.567	15.0	10.8	1.0	252.0	10.0	0.0	See Comments	QP	-19.1	6.7	50.5	-43.8	Ant. Perp to floor/perp EUT, EUT On Side
13.553	14.8	10.8	1.0	254.0	10.0	0.0	See Comments	QP	-19.1	6.5	50.5	-44.0	Ant. Perp to floor/perp EUT, EUT On Side
13.560	28.3	10.8	1.0	261.0	10.0	0.0	See Comments	QP	-19.1	20.0	84.0	-64.0	Ant. Perp to floor/perp EUT, EUT On Side
13.560	27.8	10.8	1.0	293.0	10.0	0.0	See Comments	QP	-19.1	19.5	84.0	-64.5	Ant. Perp to floor/perp EUT, EUT Vertical
13.560	22.3	10.8	1.0	191.0	10.0	0.0	See Comments	QP	-19.1	14.0	84.0	-70.0	Ant. Perp to floor/para EUT, EUT On Side
13.560	22.0	10.8	1.0	214.0	10.0	0.0	See Comments	QP	-19.1	13.7	84.0	-70.3	Ant. Perp to floor/para EUT, EUT Vert
13.560	20.1	10.8	1.0	155.0	10.0	0.0	See Comments	QP	-19.1	11.8	84.0	-72.2	Ant. Perp to floor/perp EUT, EUT Horizontal
13.560	18.4	10.8	1.0	259.0	10.0	0.0	See Comments	QP	-19.1	10.1	84.0	-73.9	Ant. Para to floor/perp EUT, EUT On Side
13.560	18.0	10.8	1.0	269.0	10.0	0.0	See Comments	QP	-19.1	9.7	84.0	-74.3	Ant. Para to floor/perp EUT, EUT Vertical
13.560	17.2	10.8	1.0	75.0	10.0	0.0	See Comments	QP	-19.1	8.9	84.0	-75.1	Ant. Perp to floor/para EUT, EUT Horizontal
13.560	12.4	10.8	1.0	310.0	10.0	0.0	See Comments	QP	-19.1	4.1	84.0	-79.9	Ant. Para to floor/perp EUT, EUT Horizontal

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FIELD STRENGTH OF SPURIOUS EMISSIONS < 30MHz

Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data. The test data represents the configuration / operating mode/ model that produced the highest emission levels as compared to the specification limit.

MODES OF OPERATION

Continuous Tx at 13.56MHz

POWER SETTINGS INVESTIGATED

Battery

CONFIGURATIONS INVESTIGATED

ONIT0011 - 1

FREQUENCY RANGE INVESTIGATED

Start Frequency 9 kHz

Stop Frequency 30 MHz

SAMPLE CALCULATIONS

Radiated Emissions: Field Strength = Measured Level + Antenna Factor + Cable Factor - Amplifier Gain + Distance Adjustment Factor + External Attenuation

TEST EQUIPMENT

Description	Manufacturer	Model	ID	Last Cal.	Interval
Cable	None	10m Test Distance Cable	EVL	5/11/2015	12 mo
Antenna, Loop	EMCO	6502	AOA	6/24/2014	24 mo
Analyzer - Spectrum Analyzer	Agilent	E4443A	AFB	3/17/2015	12 mo

TEST DESCRIPTION

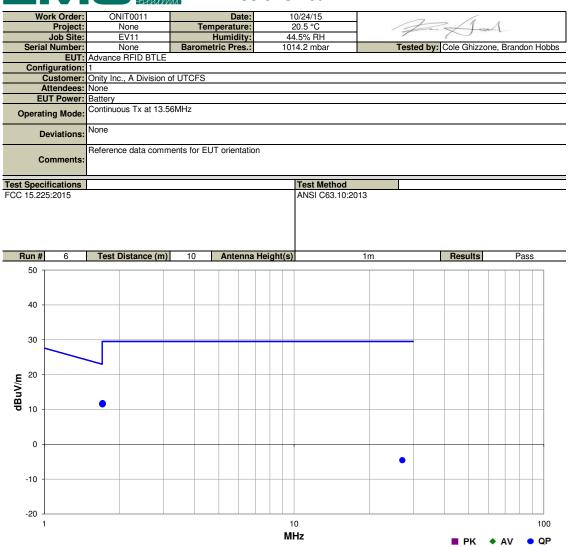
The antennas to be used with the EUT were tested. The EUT was continuously transmitting while set to the channel specified.

While scanning, emissions from the EUT were maximized by rotating the EUT, adjusting the measurement antenna height and orientation in 3 orthogonal planes, the EUT and/or associated antenna is positioned in 3 orthogonal planes (per ANSI C63.10). An active loop antenna was used for this test in order to provide sufficient measurement sensitivity.

As outlined in 15.209(e) and 15.31(f)(2), measurements may be performed at a distance closer than what is specified with the limit. The limit at the specified distance is shown on the data sheet. Measurements are made at a closer distance and the data is adjusted using a distance correction factor of 40dB/decade for comparison to the limit.



FIELD STRENGTH OF SPURIOUS EMISSIONS < 30MHz



Freq (MHz)	Amplitude (dBuV)	Factor (dB)	Antenna Height (meters)	Azimuth (degrees)	Test Distance (meters)	External Attenuation (dB)	Polarity/ Transducer Type	Detector	Distance Adjustment (dB)	Adjusted (dBuV/m)	Spec. Limit (dBuV/m)	Compared to Spec. (dB)	Comments
1.711	20.6	10.3	1.0	243.0	10.0	0.0	See Comments	QP	-19.1	11.8	29.5	-17.7	Ant. perp to floor/para EUT, EUT Vertical
1.707	20.5	10.3	1.0	264.0	10.0	0.0	See Comments	QP	-19.1	11.7	29.5	-17.8	Ant. perp to floor/para EUT, EUT On Side
1.715	20.5	10.3	1.0	282.0	10.0	0.0	See Comments	QP	-19.1	11.7	29.5	-17.8	Ant. perp to floor/para EUT, EUT Horizontal
1.710	20.4	10.3	1.0	125.0	10.0	0.0	See Comments	QP	-19.1	11.6	29.5	-17.9	Ant. para to floor/perp EUT, EUT Horizontal
1.707	20.3	10.3	1.0	93.0	10.0	0.0	See Comments	QP	-19.1	11.5	29.5	-18.0	Ant. perp to floor/perp EUT, EUT Horizontal
1.707	20.3	10.3	1.0	298.0	10.0	0.0	See Comments	QP	-19.1	11.5	29.5	-18.0	Ant. para to floor/perp EUT, EUT On Side
1.708	20.3	10.3	1.0	26.0	10.0	0.0	See Comments	QP	-19.1	11.5	29.5	-18.0	Ant. para to floor/perp EUT, EUT Vertical
1.712	20.3	10.3	1.0	365.0	10.0	0.0	See Comments	QP	-19.1	11.5	29.5	-18.0	Ant. perp to floor/perp EUT, EUT Vertical
1.712	20.3	10.3	1.0	237.0	10.0	0.0	See Comments	QP	-19.1	11.5	29.5	-18.0	Ant. perp to floor/perp EUT, EUT On Side
27.123	5.6	8.9	1.0	219.0	10.0	0.0	See Comments	QP	-19.1	-4.5	29.5	-34.1	Ant. perp to floor/para EUT, EUT Vertical

ENC

FIELD STRENGTH OF SPURIOUS EMISSIONS GREATER THAN 30 MHz

Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data. The test data represents the configuration / operating mode/ model that produced the highest emission levels as compared to the specification limit.

MODES OF OPERATION

Continuous Tx 13.56 MHz RFID		

POWER SETTINGS INVESTIGATED

Battery

CONFIGURATIONS INVESTIGATED

ONIT0011 - 1

FREQUENCY RANGE INVESTIGATED

Start Frequency 30 MHz

Stop Frequency 1000 MHz

SAMPLE CALCULATIONS

Radiated Emissions: Field Strength = Measured Level + Antenna Factor + Cable Factor - Amplifier Gain + Distance Adjustment Factor + External Attenuation

TEST EQUIPMENT

Description	Manufacturer	Model	ID	Last Cal.	Interval
Analyzer - Spectrum Analyzer	Keysight	N9010A	AFN	2/10/2015	12 mo
Cable	N/A	Bilog Cables	EVA	2/10/2015	12 mo
Amplifier - Pre-Amplifier	Miteq	AM-1616-1000	AOL	2/10/2015	12 mo
Antenna - Biconilog	EMCO	3141	AXE	8/29/2014	24 mo

TEST DESCRIPTION

The antennas to be used with the EUT were tested. The EUT was transmitting while set at the operating channel.

While scanning, emissions from the EUT were maximized by rotating the EUT, adjusting the measurement antenna height and polarization, and manipulating the EUT antenna in 3 orthogonal planes (per ANSI C63.10).



FIELD STRENGTH OF SPURIOUS EMISSIONS GREATER THAN 30 MHz

vvor	rk Order:	ONIT0011		Date:	10/2	4/15		5		
	Project:	None	Te	mperature:	21	7 °C	1	2/	1	1
	Job Site:	EV01		Humidity:	44.3	% RH		~		1
	Number:	None	Barom	etric Pres.:	1010.	5 mbar	Tested by:	Brandon Hol	bbs	
		Advance RFID BTLE								
Config	uration:	1								
Ci	ustomer:	Onity Inc., A Division	of UTCFS							
	tendees:									
	T Power:									
	ng Mode:	Continuous Tx 13.56	MHz RFID							
Dev	viations:	None								
Co	mments:	Please reference the	data comm	ents for EUT	orientatio	n				
t Specifi	ications					Test Method				
C 15.209:	2015					ANSI C63.10:2013				
Run #	1	Test Distance (m)	3	Antenna I	leight(s)	1 to 4(m	ו)	Results	Pa	ass
Run #	1	Test Distance (m)	3	Antenna I	Height(s)	1 to 4(m	ו)	Results	Pa	ass
80	1	Test Distance (m)	3	Antenna I	leight(s)	1 to 4(m	1)	Results	Pa	ass
	1	Test Distance (m)	3	Antenna I	Height(s)	1 to 4(m	n)	Results	Pa	ass
	1	Test Distance (m)	3	Antenna I	Height(s)	1 to 4(m	n)	Results	Pa	
80	1	Test Distance (m)	3	Antenna H	Height(s)	1 to 4(m	n)	Results	Pa	ass
80	1	Test Distance (m)	3	Antenna I	Height(s)	1 to 4(m	n)	Results	Pa	
80	1	Test Distance (m)	3	Antenna I	Height(s)	1 to 4(m	n)	Results	Pa	
80	1	Test Distance (m)	3	Antenna H	Height(s)	1 to 4(m	n)	Results	Pa	
80 70 60	1	Test Distance (m)	3	Antenna H	Height(s)	1 to 4(m	n)	Results	P:	ass
80 70 60 50	1	Test Distance (m)	3	Antenna H	Height(s)	1 to 4(m		Results	P:	ass
80 70 60 50	1	Test Distance (m)	3	Antenna H	Height(s)	1 to 4(m		Results	P:	ass
80 70 60 50	1	Test Distance (m)	3		Height(s)	1 to 4(m		Results	P	ass
80 70 60 50	1	Test Distance (m)	3		Height(s)	1 to 4(m		Results	P:	ass
80 70 60 50	1	Test Distance (m)	3		Height(s)	1 to 4(m		Results	P	ass
80 70 60 50	1	Test Distance (m)	3		Height(s)	1 to 4(m		Results	P:	
80	1	Test Distance (m)	3		Height(s)	1 to 4(m		Results	P:	
80	1	Test Distance (m)	3		Height(s)	1 to 4(m		Results		
80	1	Test Distance (m)	3		Height(s)	1 to 4(m		Results	P:	
80	1	Test Distance (m)	3		Height(s)	1 to 4(m		Results	P:	
80 70 60 50 50 30 20	1	Test Distance (m)	3		Height(s)	1 to 4(m		Results	P:	
80	1	Test Distance (m)	3		Height(s)	1 to 4(m		Results	P:	
80 70 60 50 50 30 20	1	Test Distance (m)	3	Antenna H	Height(s)	1 to 4(m		Results	P:	
80 70 60 50 50 30 20 10	1	Test Distance (m)	3		Height(s)	1 to 4(m		Results	P:	
80 70 60 50 50 30 20 10 0	1	Test Distance (m)	3			1 to 4(m		Results	P:	
80 70 60 50 40 30 20 10	1	Test Distance (m)	3		Height(s)	1 to 4(m		Results Image: Image of the second		ass

Freq (MHz)	Amplitude (dBuV)	Factor (dB)	Antenna Height (meters)	Azimuth (degrees)	Test Distance (meters)	External Attenuation (dB)	Polarity/ Transducer Type	Detector	Distance Adjustment (dB)	Adjusted (dBuV/m)	Spec. Limit (dBuV/m)	Compared to Spec. (dB)	Comments
40.688	20.3	-6.4	1.0	95.0	3.0	0.0	Vert	QP	0.0	13.9	40.0	-26.1	EUT On Side
40.687	17.4	-6.4	3.6	232.0	3.0	0.0	Vert	QP	0.0	11.0	40.0	-29.0	EUT Vertical
40.686	17.2	-6.4	4.0	305.0	3.0	0.0	Horz	QP	0.0	10.8	40.0	-29.2	EUT On Side
40.692	16.8	-6.4	2.7	7.0	3.0	0.0	Horz	QP	0.0	10.4	40.0	-29.6	EUT Vertical
40.673	16.7	-6.4	1.0	32.0	3.0	0.0	Horz	QP	0.0	10.3	40.0	-29.7	EUT Horizontal
40.734	16.5	-6.5	1.0	252.0	3.0	0.0	Vert	QP	0.0	10.0	40.0	-30.0	EUT Horizontal
54.011	17.1	-10.0	1.0	21.0	3.0	0.0	Vert	QP	0.0	7.1	40.0	-32.9	EUT On Side
54.254	17.0	-10.1	1.0	274.0	3.0	0.0	Horz	QP	0.0	6.9	40.0	-33.1	EUT On Side
67.801	17.7	-11.3	1.0	282.0	3.0	0.0	Vert	QP	0.0	6.4	40.0	-33.6	EUT On Side
67.800	16.8	-11.3	1.0	360.0	3.0	0.0	Horz	QP	0.0	5.5	40.0	-34.5	EUT On Side

PSA-ESCI 2015.07.01 EmiR5 2015.08.28



Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

TEST EQUIPMENT

					Interval
Description	Manufacturer	Model	ID	Last Cal.	(mo)
Chamber - Temperature/Humidity	Cincinnati Sub Zero (CSZ)	ZPH-8-2-SCT/AC	TBI	NCR	0
Meter - Multimeter	Tektronix	DMM912	MMH	2/5/2013	36
Power Supply - DC	Tektronix	PS280	TPM	NCR	0
Thermometer	Omegaette	HH311	DTY	1/21/2015	36
Probe - Near Field Set	EMCO	7405	IPD	NCR	0
Attenuator	S.M. Electronics	SA26B-20	AUY	7/14/2015	12
Block - DC	Fairview Microwave	SD3379	AMP	6/18/2015	12
Analyzer - Spectrum Analyzer	Agilent	E4446A	AAQ	3/10/2015	12

TEST DESCRIPTION

A near field measurement was made between the EUT's integral antenna and a spectrum analyzer. The spectrum analyzer is equipped with a precision frequency reference that exceeds the stability requirement of the EUT.

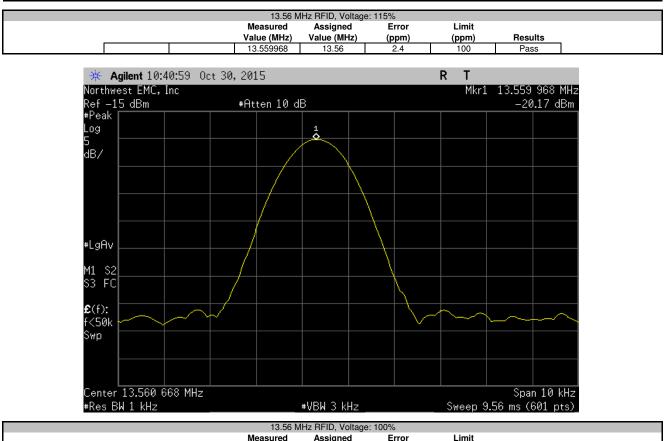
Measurements were made on the single transmit frequency as called out on the data sheets. Testing was done while the EUT was continuously poling.

Per the frequency stability requirements for rule part 2.1055 the primary supply voltage was varied from 85 % to 115% of the nominal voltage Using a temperature chamber, the transmit frequency was recorded at the extremes of the specified temperature range (-30 ° to +50° C) and at 10°C intervals.

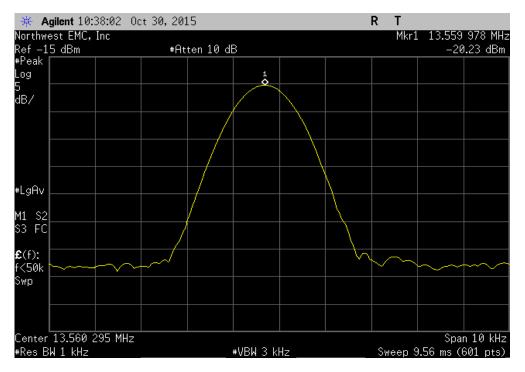
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	Advance RFID BTLE						Work Order:		
Serial Number								10/30/15	
Customer	: Onity Inc., A Division of L	JTCFS					Temperature:		
Attendees							Humidity:		
Project	None					E	Barometric Pres.:	1012 mbar	
Tested by	Brandon Hobbs			Power: Battery (6VDC No	ominal)		Job Site:	EV06	
TEST SPECIFICAT	LIONS			Test Method					
FCC 15.225:2015				ANSI C63.10:2013	}				
COMMENTS									
The FLIT is operat	ing at 100% duty cycle.								
	ing at 100% daty cycle.								
DEVIATIONS FRO	M TEST STANDARD								
None									
	1		1	-11					
None Configuration #	1	Signature	1	a Jar					
	1	Signature	1	a Jan	Measured	Assigned	Frror	Limit	
	1	Signature	1	a Jar	Measured Value (MHz)	Assigned Value (MHz)	Error (ppm)	Limit (ppm)	Results
Configuration #	1	Signature	4	a Jan	Measured Value (MHz)	Assigned Value (MHz)	Error (ppm)	Limit (ppm)	Results
Configuration #	1 Voltage: 115%	Signature	1	the Jar	Value (MHz)	Value (MHz)	(ppm)	(ppm)	
Configuration #	1 Voltage: 115% Voltage: 100%	Signature	4	The Jan	Value (MHz) 13.559968	Value (MHz) 13.56	(ppm) 2.4	(ppm) 100	Pass
Configuration #	Voltage: 100%	Signature	4	-J-A	Value (MHz) 13.559968 13.559978	Value (MHz) 13.56 13.56	(ppm) 2.4 1.6	(ppm) 100 100	Pass Pass
Configuration #	Voltage: 100% Voltage: 85%	Signature	1	the Jan	Value (MHz) 13.559968 13.559978 13.559978	Value (MHz) 13.56 13.56 13.56	(ppm) 2.4 1.6 1.6	(ppm) 100 100 100	Pass Pass Pass
Configuration #	Voltage: 100% Voltage: 85% Temperature: +50°	Signature	1	To Jan	Value (MHz) 13.559968 13.559978 13.559978 13.559967	Value (MHz) 13.56 13.56 13.56 13.56 13.56	(ppm) 2.4 1.6 1.6 2.4	(ppm) 100 100 100 100	Pass Pass Pass Pass
Configuration #	Voltage: 100% Voltage: 85% Temperature: +50° Temperature: +40°	Signature	1	The Jar	Value (MHz) 13.559968 13.559978 13.559978 13.559967 13.559972	Value (MHz) 13.56 13.56 13.56 13.56 13.56 13.56	(ppm) 2.4 1.6 1.6 2.4 2.1	(ppm) 100 100 100 100 100 100	Pass Pass Pass Pass Pass Pass
Configuration #	Voltage: 100% Voltage: 85% Temperature: +50° Temperature: +40° Temperature: +30°	Signature	1	the Jan	Value (MHz) 13.559968 13.559978 13.559978 13.559967 13.559967 13.559972 13.559977	Value (MHz) 13.56 13.56 13.56 13.56 13.56 13.56 13.56	(ppm) 2.4 1.6 2.4 2.1 1.7	(ppm) 100 100 100 100 100 100 100	Pass Pass Pass Pass Pass Pass
Configuration #	Voltage: 100% Voltage: 85% Temperature: +50° Temperature: +40° Temperature: +30° Temperature: +20°	Signature	2	a Jar	Value (MHz) 13.559968 13.559978 13.559978 13.559977 13.559977 13.559976	Value (MHz) 13.56 13.56 13.56 13.56 13.56 13.56 13.56 13.56	(ppm) 2.4 1.6 1.6 2.4 2.1 1.7 3.2	(ppm) 100 100 100 100 100 100 100	Pass Pass Pass Pass Pass Pass Pass
Configuration #	Voltage: 100% Voltage: 85% Temperature: +50° Temperature: +40° Temperature: +30° Temperature: +20° Temperature: +10°	Signature	2	the Jar	Value (MHz) 13.559968 13.559978 13.559978 13.559972 13.559977 13.559977 13.559956 13.56002	Value (MHz) 13.56 13.56 13.56 13.56 13.56 13.56 13.56 13.56 13.56 13.56	(ppm) 2.4 1.6 2.4 2.1 1.7 3.2 1.5	(ppm) 100 100 100 100 100 100 100 100	Pass Pass Pass Pass Pass Pass Pass Pass
Configuration #	Voltage: 100% Voltage: 85% Temperature: +50° Temperature: +40° Temperature: +30° Temperature: +10° Temperature: 0°	Signature	2	The Jan	Value (MHz) 13.559968 13.559978 13.559978 13.559977 13.559977 13.559977 13.559977 13.559956 13.56002	Value (MHz) 13.56 13.56 13.56 13.56 13.56 13.56 13.56 13.56 13.56 13.56	(ppm) 2.4 1.6 2.4 2.1 1.7 3.2 1.5 1.7	(ppm) 100 100 100 100 100 100 100 10	Pass Pass Pass Pass Pass Pass Pass Pass
	Voltage: 100% Voltage: 85% Temperature: +50° Temperature: +40° Temperature: +30° Temperature: +20° Temperature: 0° Temperature: 0°	Signature	1	The Jar	Value (MHz) 13.559968 13.559978 13.559978 13.559967 13.559977 13.559977 13.559977 13.559956 13.56002 13.560023 13.560038	Value (MHz) 13.56 13.56 13.56 13.56 13.56 13.56 13.56 13.56 13.56 13.56 13.56	(ppm) 2.4 1.6 1.6 2.4 2.1 1.7 3.2 1.5 1.7 2.8	(ppm) 100 100 100 100 100 100 100 10	Pass Pass Pass Pass Pass Pass Pass Pass
Configuration #	Voltage: 100% Voltage: 85% Temperature: +50° Temperature: +40° Temperature: +30° Temperature: +10° Temperature: 0°	Signature	4	the Jan	Value (MHz) 13.559968 13.559978 13.559978 13.559977 13.559977 13.559977 13.559977 13.559956 13.56002	Value (MHz) 13.56 13.56 13.56 13.56 13.56 13.56 13.56 13.56 13.56 13.56	(ppm) 2.4 1.6 2.4 2.1 1.7 3.2 1.5 1.7	(ppm) 100 100 100 100 100 100 100 10	Pass Pass Pass Pass Pass Pass Pass Pass

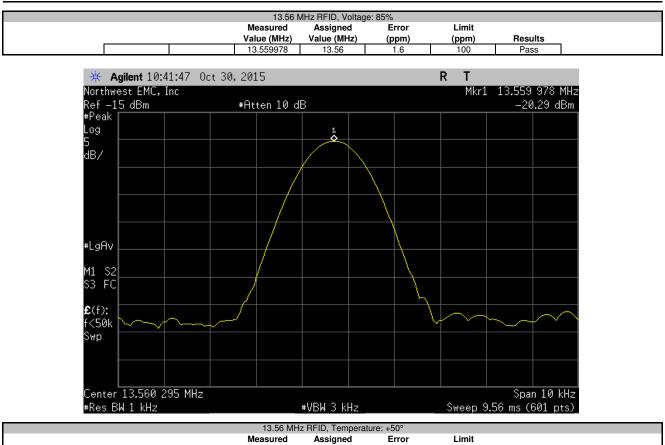




	Measured	Assigned	Error	Limit	
	Value (MHz)	Value (MHz)	(ppm)	(ppm)	Results
	13.559978	13.56	1.6	100	Pass







	Measu	ured Assign	ed Error	Limit	
	Value (MHz) Value (N	/IHz) (ppm)	(ppm)	Results
	13.559	9967 13.56	6 2.4	100	Pass

